



HGE055NE4A

General Description:

HGE055NE4A, the silicon N-channel Enhanced VDMOSFETs, is obtained by the high density Trench technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is SOP8, which accords with the RoHS standard.

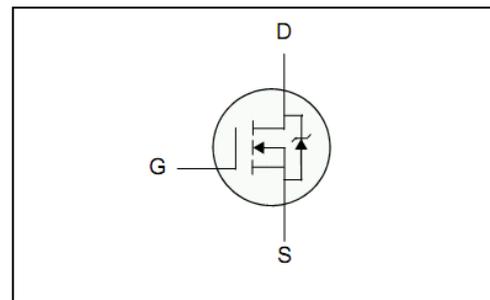
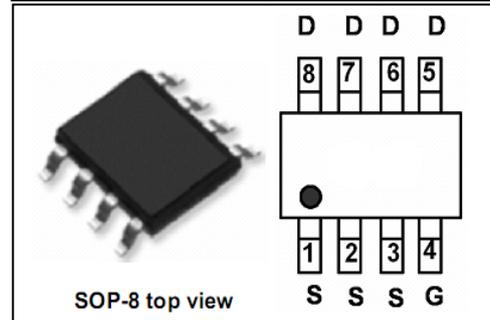
Features:

- **Fast Switching**
- **Low ON Resistance** ($R_{dson} \leq 5.5m\Omega$)
- **Low Gate Charge**
- **Low Reverse transfer capacitances**
- **100% Single Pulse avalanche energy Test**

Applications:

- Power switch circuit of adaptor and charger.
- Synchronus Rectification in DC/DC Converters

| | | |
|------------------------------|-----|----|
| V_{DSS} | 45 | V |
| I_D | 18 | A |
| $P_D(T_a=25^\circ C)$ | 3.1 | W |
| $R_{DS(ON) Typ@V_{gs}=10V}$ | 4.4 | mΩ |
| $R_{DS(ON) Typ@V_{gs}=4.5V}$ | 6.5 | mΩ |



Absolute ($T_a = 25^\circ C$ unless otherwise specified):

| Symbol | Parameter | Rating | Units |
|----------------|--|-----------------|------------|
| V_{DSS} | Drain-to-Source Voltage | 45 | V |
| I_D | Continuous Drain Current | 18 | A |
| | Continuous Drain Current $T_C = 100^\circ C$ | 11.9 | A |
| I_{DM}^{a1} | Pulsed Drain Current | 72 | A |
| V_{GS} | Gate-to-Source Voltage | ± 18 | V |
| E_{AS}^{a2} | Single Pulse Avalanche Energy | 115.5 | mJ |
| P_D | Power Dissipation | 3.1 | W |
| T_J, T_{stg} | Operating Junction and Storage Temperature Range | 150, -55 to 150 | $^\circ C$ |

**Electrical Characteristics** ($T_a = 25^\circ\text{C}$ unless otherwise specified):

| OFF Characteristics | | | | | | |
|----------------------------|-----------------------------------|---|--------|------|------|---------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| V_{DSS} | Drain to Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 45 | -- | -- | V |
| I_{DSS} | Drain to Source Leakage Current | $V_{DS}=450V, V_{GS}=0V,$ $T_A = 25^\circ\text{C}$ | -- | -- | 1 | μA |
| | | $V_{DS}=36V, V_{GS}=0V,$ $T_A = 125^\circ\text{C}$ | -- | -- | 100 | |
| $I_{GSS(F)}$ | Gate to Source Forward Leakage | $V_{GS}=+18V$ | -- | -- | 100 | nA |
| $I_{GSS(R)}$ | Gate to Source Reverse Leakage | $V_{GS}=-18V$ | -- | -- | -100 | nA |

| ON Characteristics | | | | | | |
|--|-------------------------------|-----------------------------------|--------|------|------|-----------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| $R_{DS(ON)}$ | Drain-to-Source On-Resistance | $V_{GS}=10V, I_D=18A$ | -- | 4.4 | 5.5 | $m\Omega$ |
| | | $V_{GS}=4.5V, I_D=14A$ | -- | 6.5 | 8.2 | $m\Omega$ |
| $V_{GS(TH)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 1.0 | 1.75 | 2.5 | V |
| Pulse width $t_p \leq 300\mu s, \delta \leq 2\%$ | | | | | | |

| Dynamic Characteristics | | | | | | |
|--------------------------------|------------------------------|--|--------|------|------|----------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| R_g | Gate resistance | $f=1\text{MHz}$ | -- | 2 | -- | Ω |
| C_{iss} | Input Capacitance | $V_{GS} = 0V, V_{DS} = 25V$ $f = 1.0\text{MHz}$ | -- | 1156 | -- | pF |
| C_{oss} | Output Capacitance | | -- | 493 | -- | |
| C_{riss} | Reverse Transfer Capacitance | | -- | 32 | -- | |

| Resistive Switching Characteristics | | | | | | |
|--|---------------------------------|---|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| $t_{d(ON)}$ | Turn-on Delay Time | $V_{DD}=25V, I_D=19A,$ $V_{GS}=10V, R_G=3\Omega$ | -- | 10.4 | -- | ns |
| t_r | Rise Time | | -- | 6 | -- | |
| $t_{d(OFF)}$ | Turn-Off Delay Time | | -- | 30.8 | -- | |
| t_f | Fall Time | | -- | 6.4 | -- | |
| Q_g | Total Gate Charge | $V_{GS}=10V, V_{DD}=25V,$ $I_D=19A$ | -- | 24 | -- | nC |
| Q_{gs} | Gate to Source Charge | | -- | 3.2 | -- | |
| Q_{gd} | Gate to Drain ("Miller") Charge | | -- | 6.7 | -- | |

| Source-Drain Diode Characteristics | | | | | | |
|---|--|------------------------------------|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| I_S | Continuous Source Current (Body Diode) | $T_C = 25\text{ }^\circ\text{C}$ | -- | -- | 18 | A |
| I_{SM} | Maximum Pulsed Current (Body Diode) | | -- | -- | 72 | A |
| V_{SD} | Diode Forward Voltage | $I_S=18\text{A}, V_{GS}=0\text{V}$ | -- | -- | 1.2 | V |
| t_{rr} | Reverse Recovery Time | $di/dt=100\text{A}/\mu\text{s}$ | -- | 41.9 | | ns |
| Q_{rr} | Reverse Recovery Charge | $I_F=20\text{A}$ | -- | 40 | | nC |
| Pulse width $t_p \leq 300\ \mu\text{s}$, $\delta \leq 2\%$ | | | | | | |

| Symbol | Parameter | Max. | Units |
|-----------------|---------------------|------|---------------------------|
| $R_{\theta JA}$ | Junction-to-Ambient | 40 | $^\circ\text{C}/\text{W}$ |

Notes:

- ^{a1}: Repetitive rating; pulse width limited by maximum junction temperature
- ^{a2}: $L=0.5\text{mH}$, $I_D=21.5\text{A}$, Start $T_j=25\text{ }^\circ\text{C}$
- ^{a3}: Recommend soldering temperature defined by IPC/JEDEC J-STD 020

Characteristics Curve:

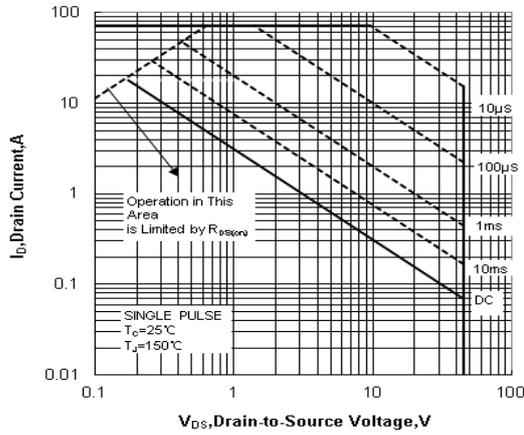


Figure 1 . Maximum Safe Operating Area

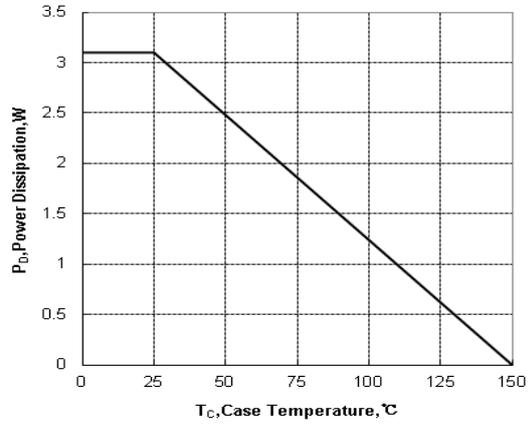


Figure 2. Maximum Power Dissipation vs Case Temperature

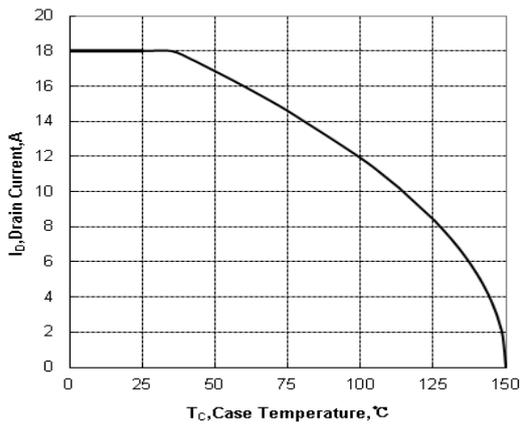


Figure 3. Maximum Continuous Drain Current vs Case Temperature

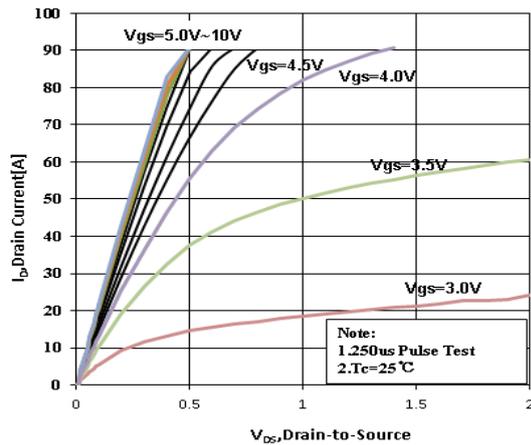


Figure 4. Typical output Characteristics

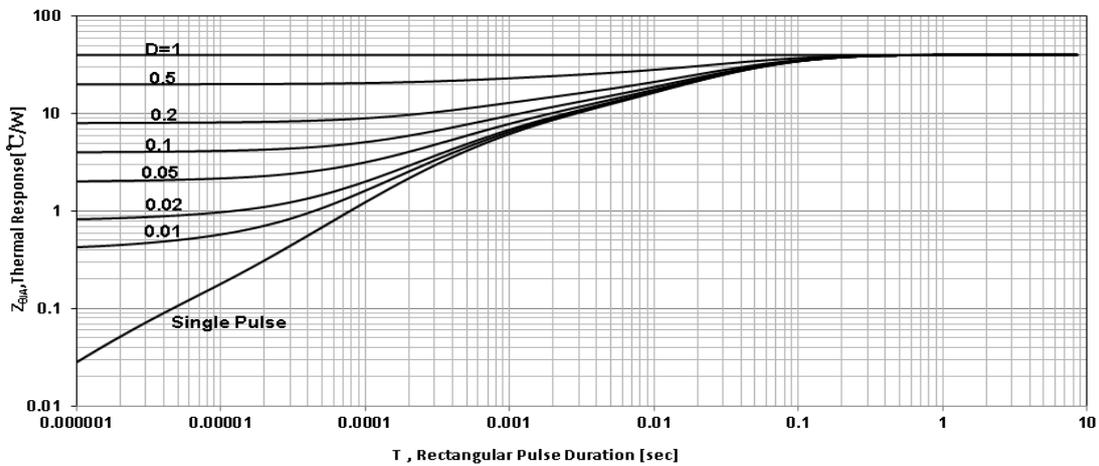


Figure 5 Maximum Effective Thermal Impedance , Junction to Ambient

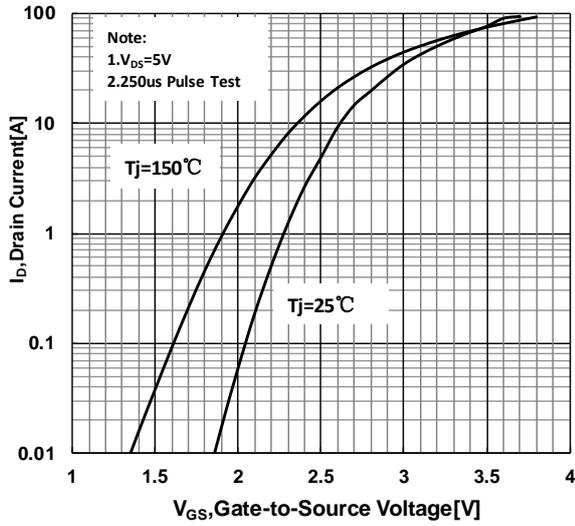


Figure 6 Typical Transfer Characteristics

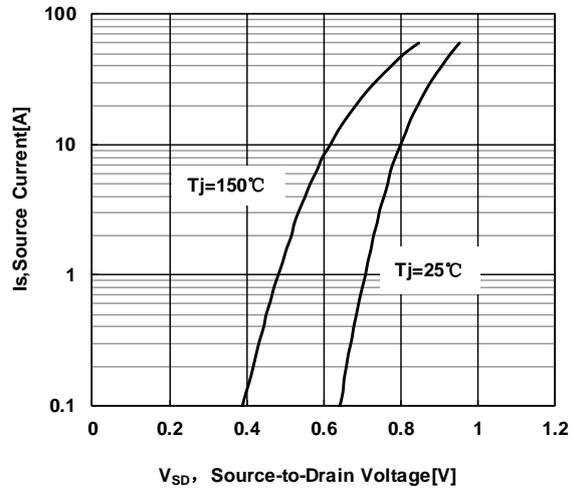


Figure 7 Typical Body Diode Transfer Characteristics

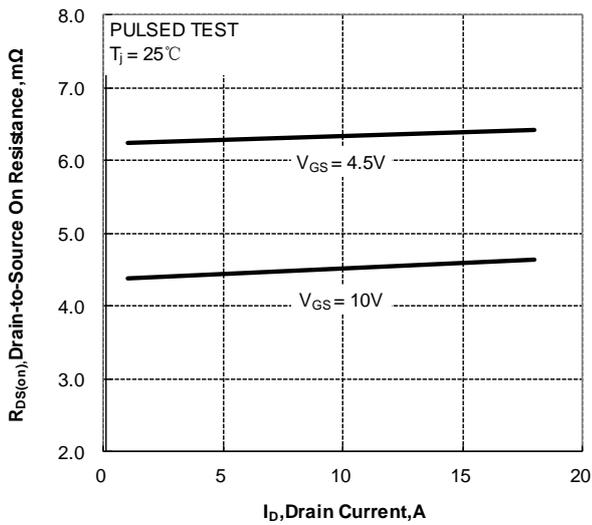


Figure 8. Drain-to-Source On Resistance vs Drain Current

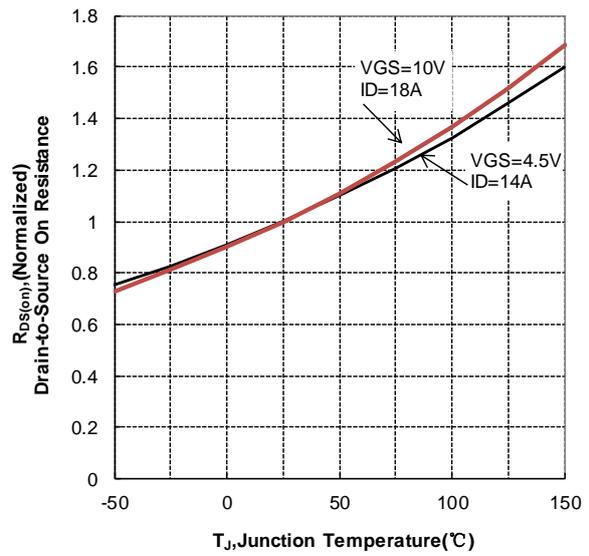


Figure 9. Normalized On Resistance vs Junction Temperature

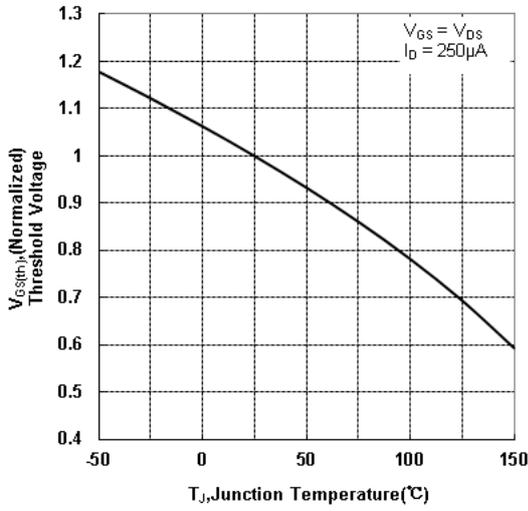


Figure 10. Normalized Threshold Voltage vs Junction Temperature

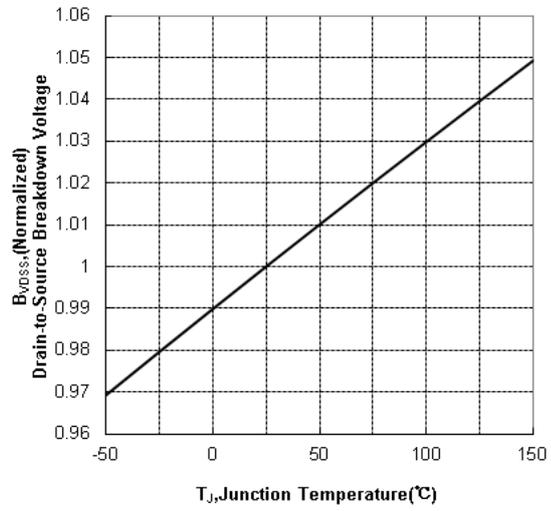


Figure 11. Normalized Breakdown Voltage vs Junction Temperature

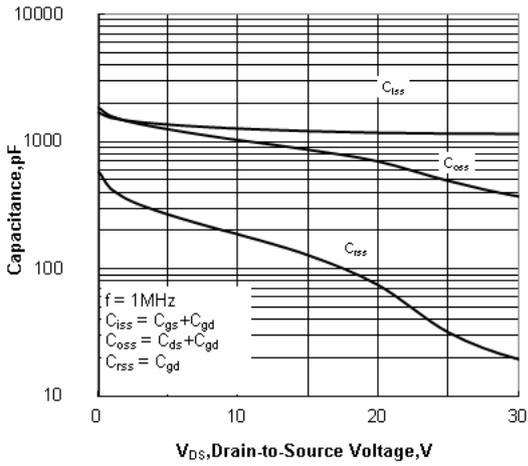


Figure 12. Capacitance Characteristics

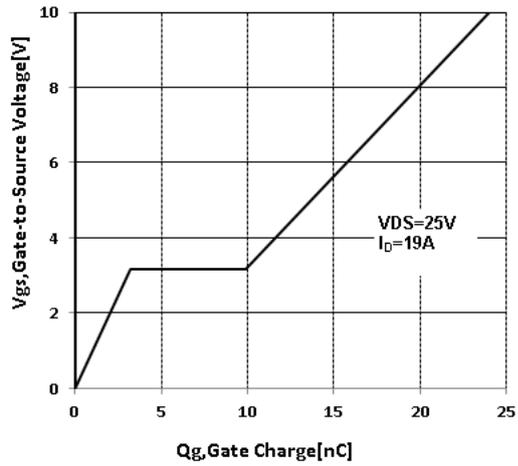


Figure 13 Typical Gate Charge vs Gate to Source Voltage

Test Circuit and Waveform

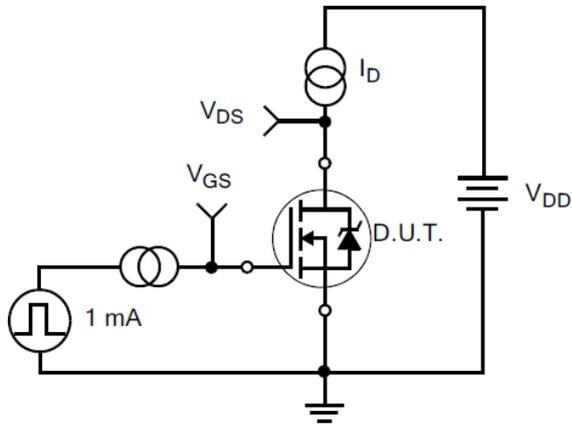


Figure 14. Gate Charge Test Circuit

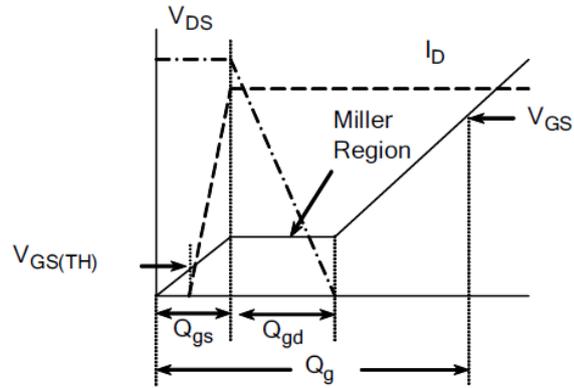


Figure 15. Gate Charge Waveforms

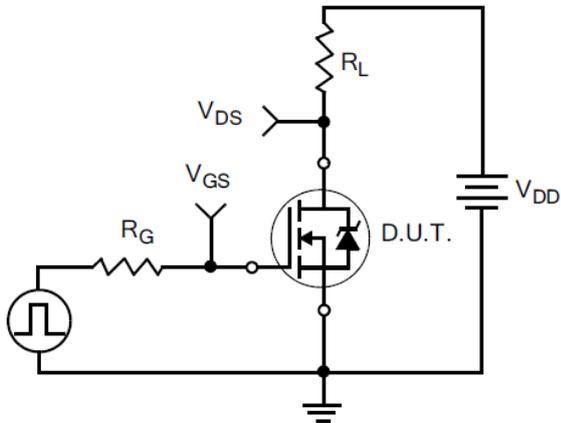


Figure 16. Resistive Switching Test Circuit

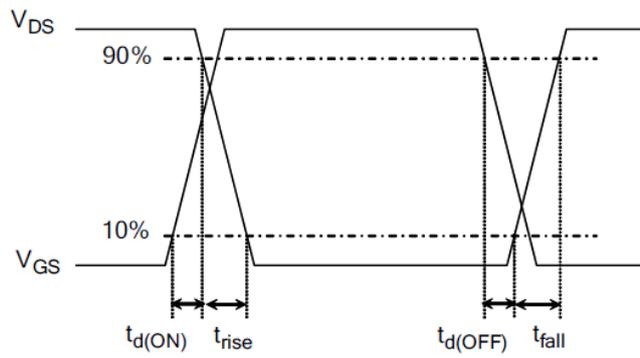


Figure 17. Resistive Switching Waveforms

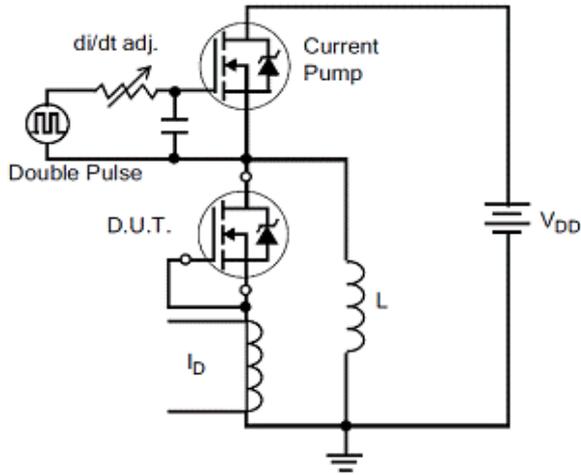


Figure 18. Diode Reverse Recovery Test Circuit

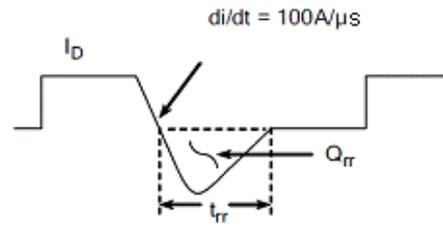


Figure 19. Diode Reverse Recovery Waveform

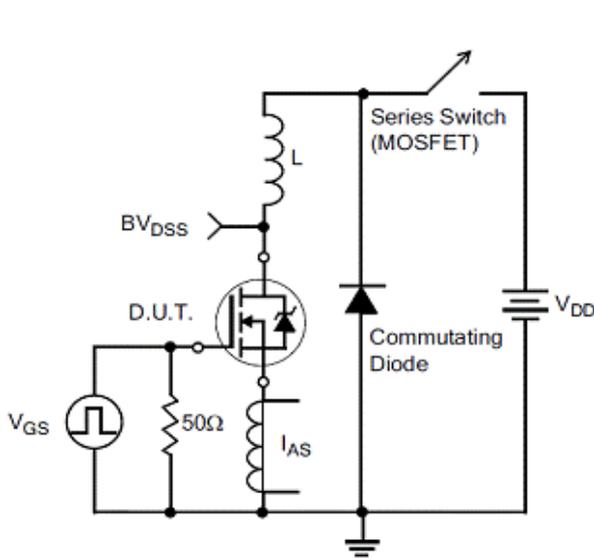


Figure 20. Unclamped Inductive Switching Test Circuit

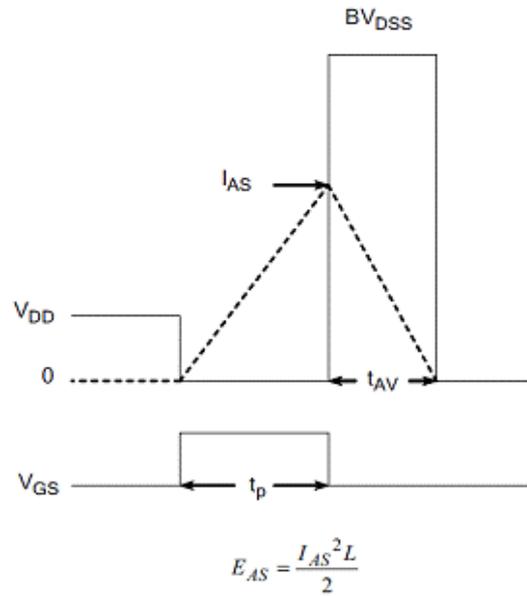
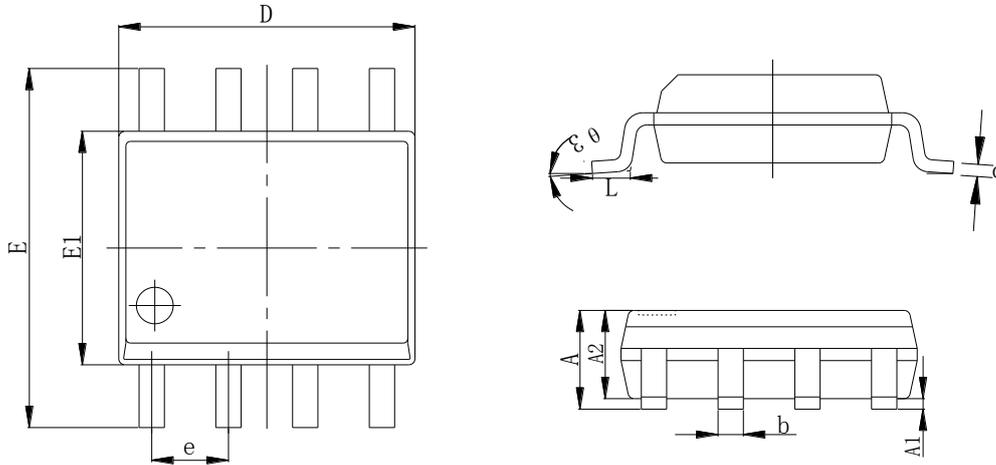


Figure 21. Unclamped Inductive Switching Waveform

Package Information:



| Items | Values(mm) | |
|----------|------------|------|
| | MIN | MAX |
| A | 1.30 | 1.80 |
| A1 | 0.10 | 0.25 |
| A2 | 1.30 | 1.50 |
| E | 5.80 | 6.20 |
| E1 | 3.80 | 4.00 |
| D | 4.80 | 5.00 |
| L | 0.40 | 0.90 |
| e | 1.27 TYP | |
| b | 0.37 | 0.47 |
| c | 0.20 TYP | |
| θ | 0° | 8° |

SOP8 Package

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